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# SiPM Basic Survival Guide

Sergey Los for EDIT-2018

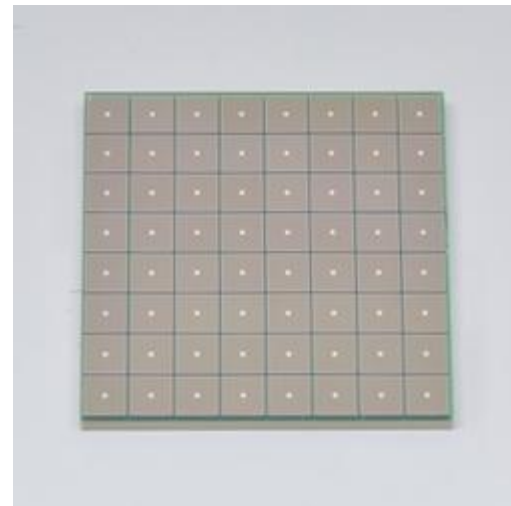
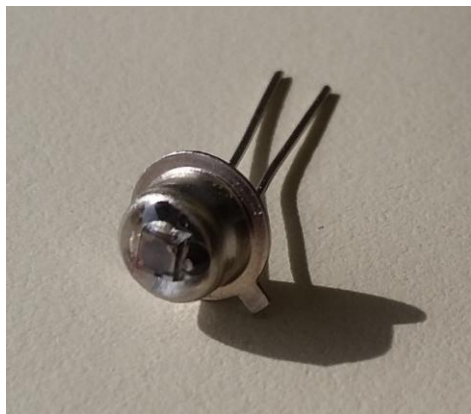
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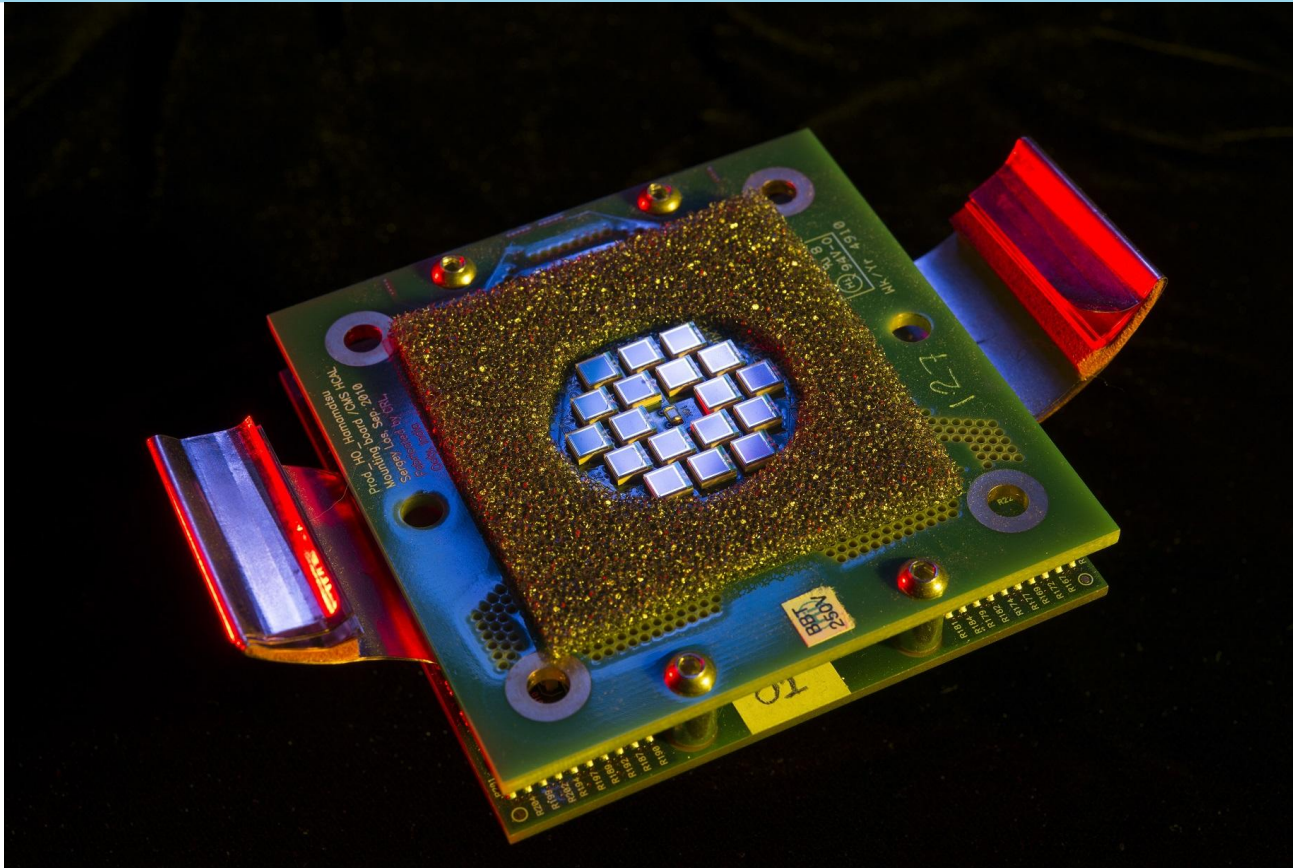


# What is a Silicon Photo-Multiplier?

- SiPM is a solid state multi-pixel Geiger mode photo-detector
- The main reason why they are called Silicon Photo-multipliers is that they have a similar gain and are replacing vacuum Photo tubes in many applications
- Since their first practical introduction about 15 years ago
  - Available now in arrays up to  $24 \times 24 \text{ mm}^2$
  - Photo detection efficiency around 50%
  - Price of about \$10 for a  $3 \times 3 \text{ mm}^2$  device
  - Pixel size between 10 and 100  $\mu\text{m}$



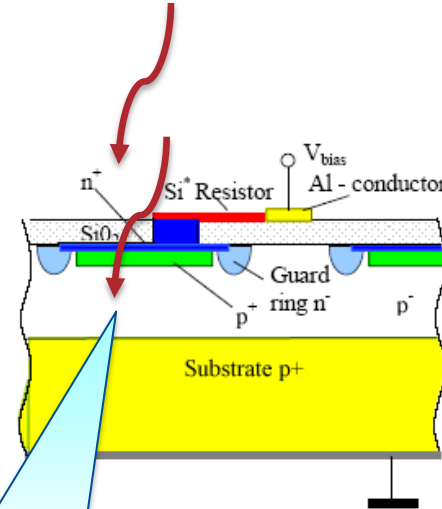
# Do SiPMs Exist in Everyday Life?



- They do! Here is a photograph of the first SiPM upgrade for CMS HCAL detector at LHC
- Eighteen  $3 \times 3 \text{ mm}^2$  SiPMs replace a vacuum photo-cathod based HPD (hybrid photo-detector)
- Circa 2007-2011

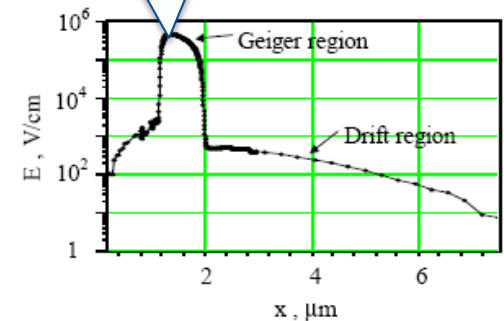
# How Does it Work?

- Photo-effect in semiconductor
- Avalanche gain in a high field region
- Self-quenching due to field drop
- Pulses from all pixels are being added together to generate a signal proportional to the incident light intensity
- Number of pixels determine the output signal dynamic range



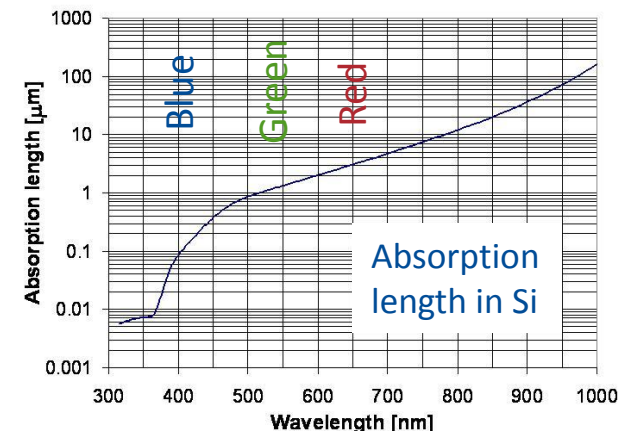
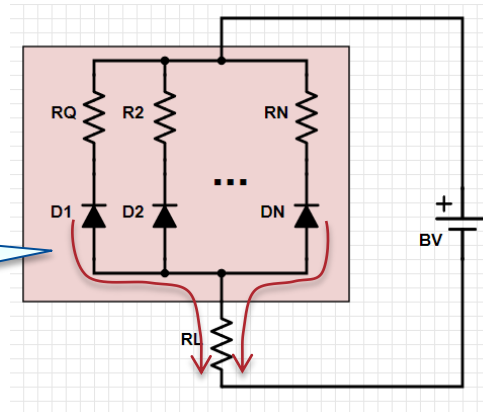
1. Conversion area, electrons drift back to the gain region

2. Avalanche causes voltage drop and quenches itself



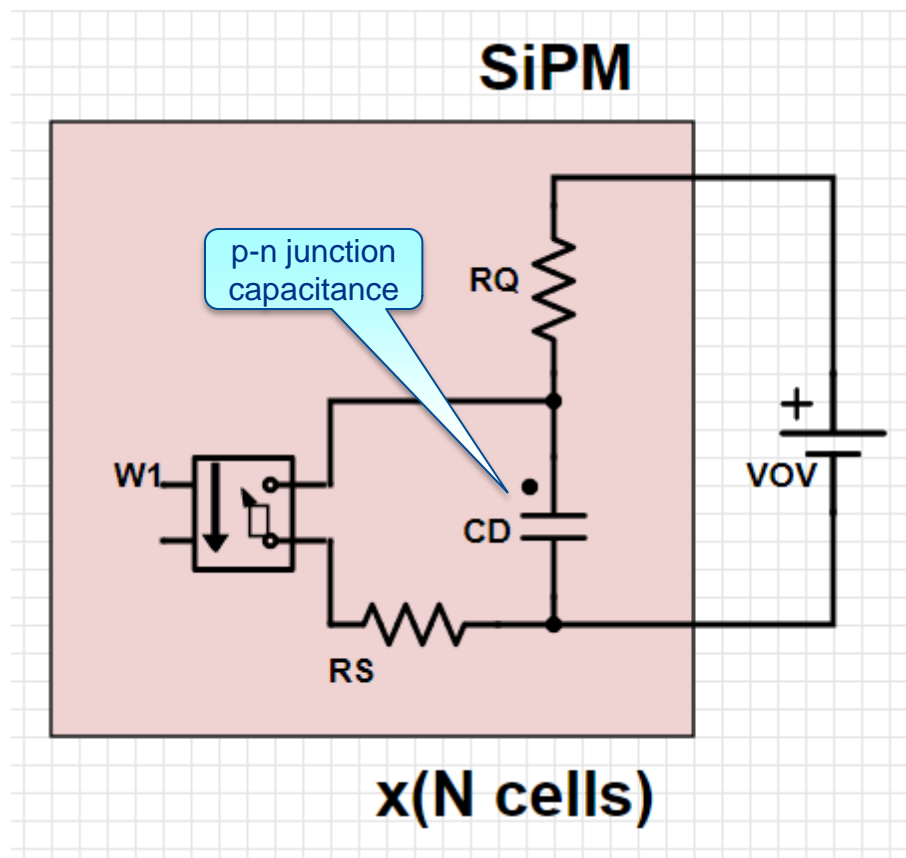
Diagrams from B. Dolgoshein et. al., "An advanced study of silicon photomultiplier", ICFA-2001

3. Output signal is a sum of individual pulses from all micropixels



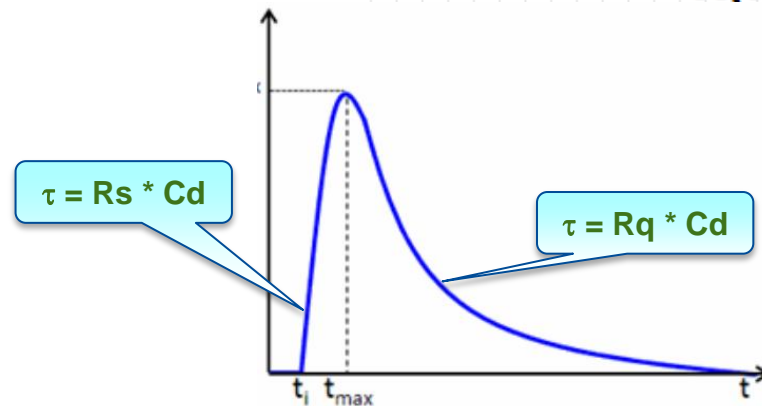
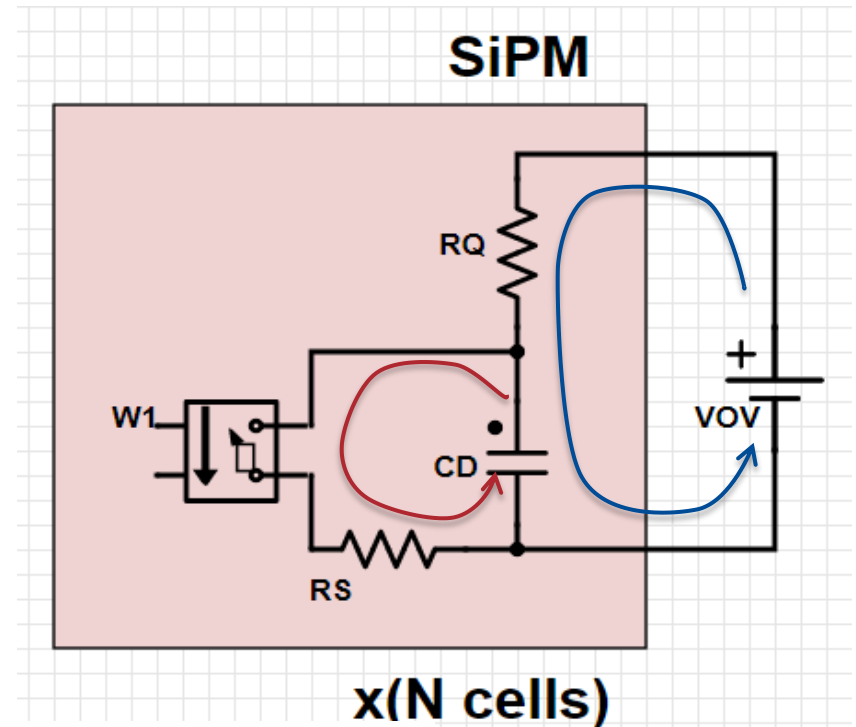
# SiPM Simplified Electric Diagram

- **Main parameters of a SiPM:**
- $V_{br}$  – breakdown voltage, more or less when gain starts being seen, usually is a linear approximation of a gain curve (good linear fit at +0.5V and above)
- PDE – photon detection efficiency ( $\approx 50\%$ )
- $N$  – Pixel number
- $C_d$  – Capacitance of an individual pixel
  - $C_d \approx C_{tot} / N$
- $R_q$  – Quenching resistor
  - Provides cell recovery
  - Limits recovery current
- $R_s$  - Avalanche resistance of a pixel
  - Not a fixed value
- Switch on the diagram turns ON when an electron gets to the gain region and causes a hot carrier discharge; OFF when current drops below a threshold value (since  $R_s \ll R_q$ , that happens when  $V = V_{br}$ )
- $V_{ov}$  – over-voltage =  $BV - V_{br}$
- What is SiPM gain?  $G = (C_d \times V_{ov}) / Q_e$ 
  - Typically  $10^6$  or 160 fC/pe ( $Q_e = 1.6E-19$  C )



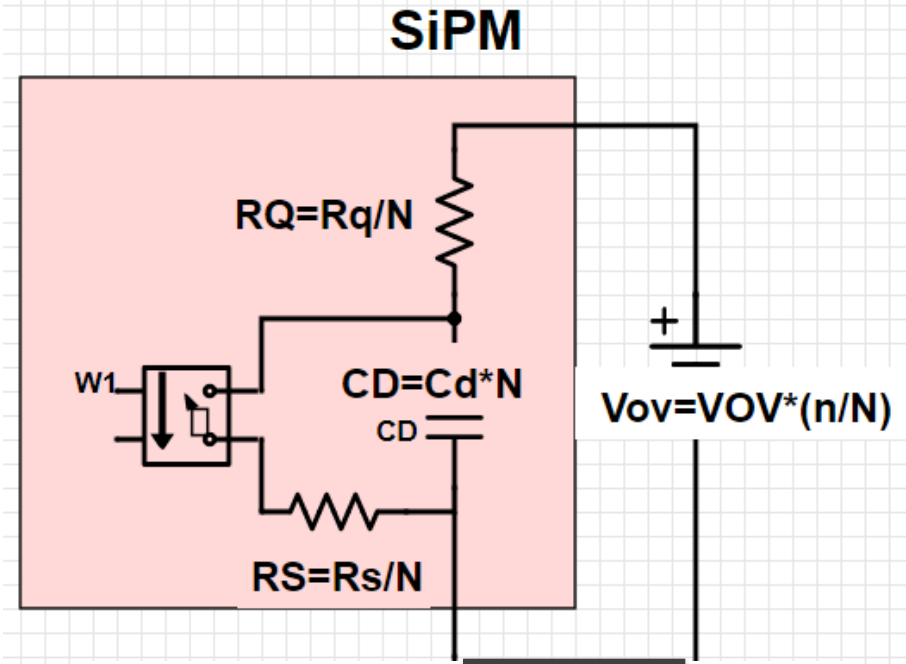
# SiPM Signal Rise and Fall Times

- When a carrier starts an avalanche in a single pixel, plasma in the gain region shorts the pixel with an equivalent resistance  $R_s$  and voltage across the pixel drops approximately as:
  - $V = V_{ov} * \exp(-t / R_s * C_d)$
  - Rise time constant  $\tau = R_s * C_d$  (<100ps)
- From the moment when avalanche quenches, pixel capacitance is being recharged via  $R_q$ :
  - $V = V_{ov}[1 - \exp(-t / R_q * C_d)]$ ,  $\tau = R_q * C_d$  ( $\approx 10\text{ns}$ )
- Self-discharge of a pixel can not be seen from outside, what we see is a current developed across  $R_q$  as the voltage drops across the pixel (and increases across  $R_q$ )
  - $I_q(\text{max}) = V_{ov} / R_q$



# Multi-Pixel Signal

- Multiple pixels firing at the same time
  - Each pixel is loaded with  $N$  identical circuits (including itself), from a signal point of view that is a frequency-compensated divider and the output pulse shape does not change, just scales with the number of the pixels fired
  - $I(n) = I(1) * n$
- To analyze output pulse shape it is convenient to use a diagram with all pixels combined in a single cell
  - For simulation the number of pixel fired can be represented by a fraction of actual overvoltage
  - Number of the pixels fired does not mean there were  $n/PDE$  incident photons (even on average), since there is a combinatorial probability for the same cell to be hit with multiple photo-electrons (pe)
  - Number of the incident photons can be calculated (with a certain accuracy)
  - Thus dynamic range of a SiPM measurement can go well beyond the pixel number  $N$



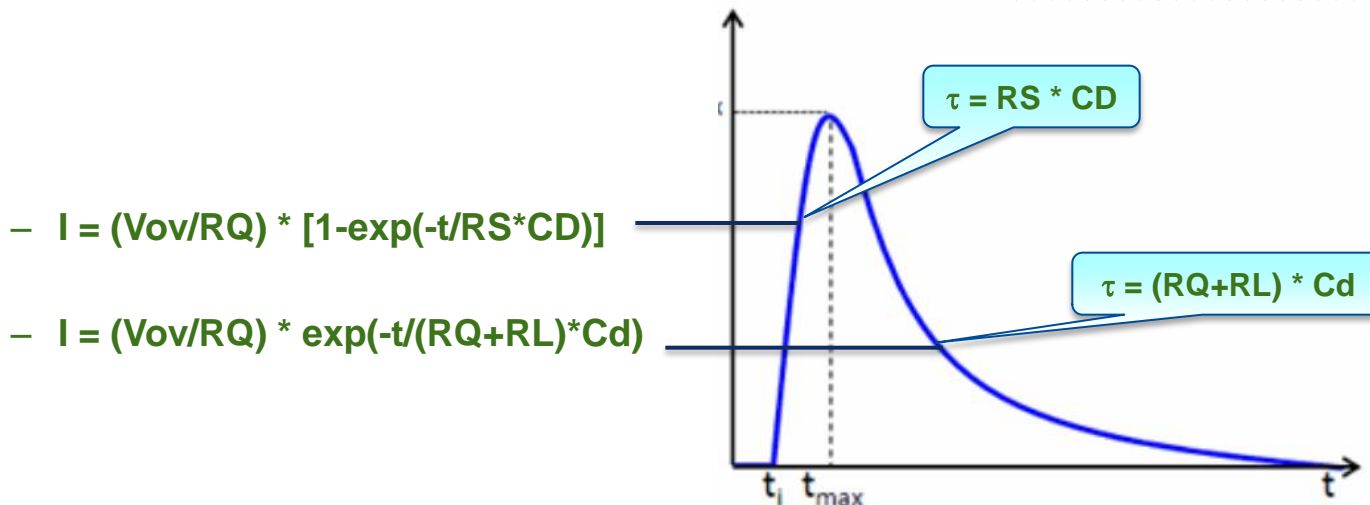
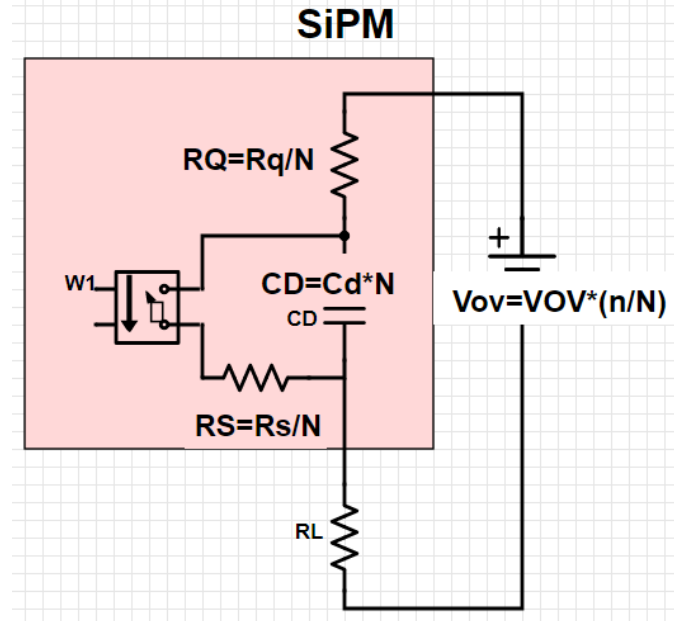
Maximum SiPM output current (when all pixels have fired)

$$I(\max) = V_{ov} / R_Q \quad R_Q = R_q / N$$

# Pulse Shape with non-Zero Load

- For this simplified equivalent diagram of a SiPM:

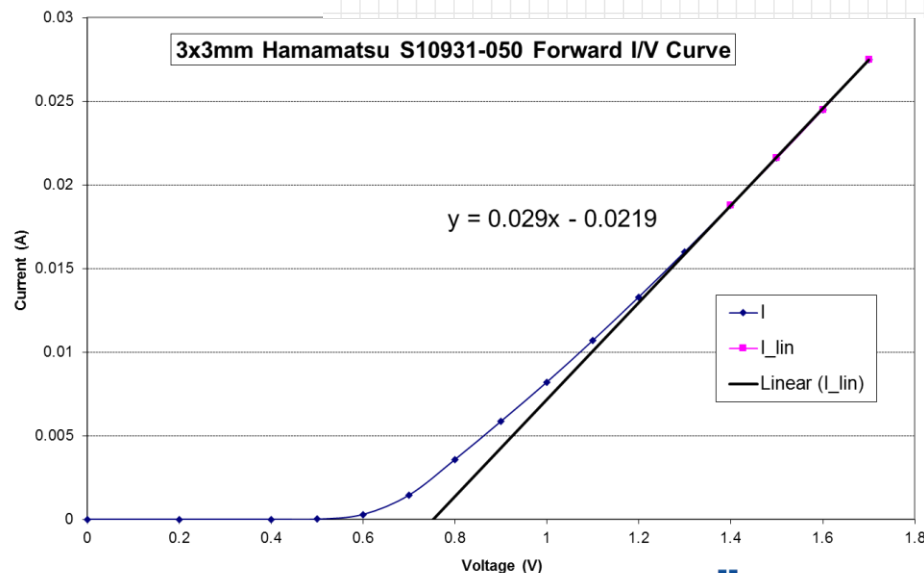
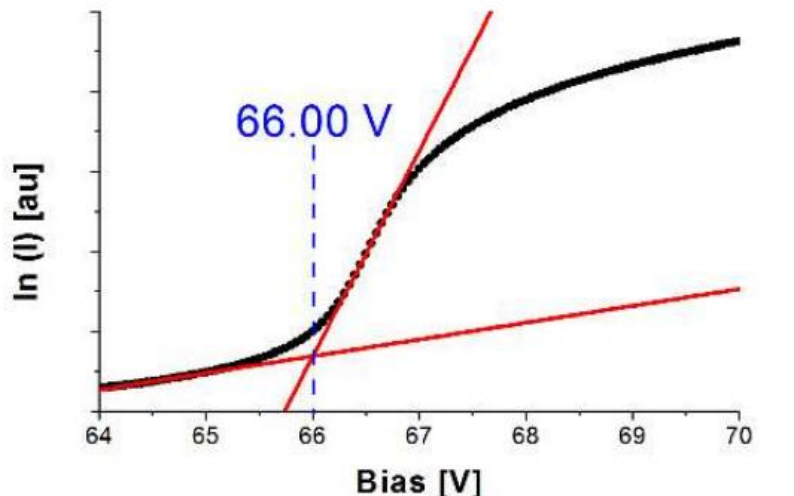
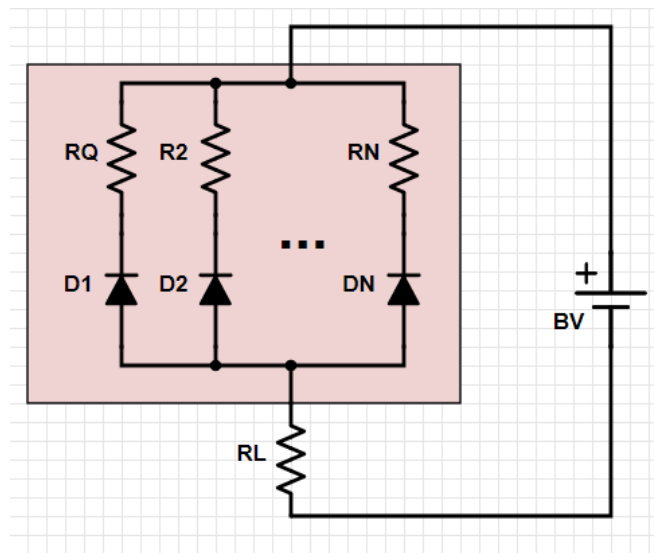
- Rise time of the signal does not depend on the input impedance of the load (amplifier)
- Fall time does increase since now both the RQ and RL are in the recharging circuit



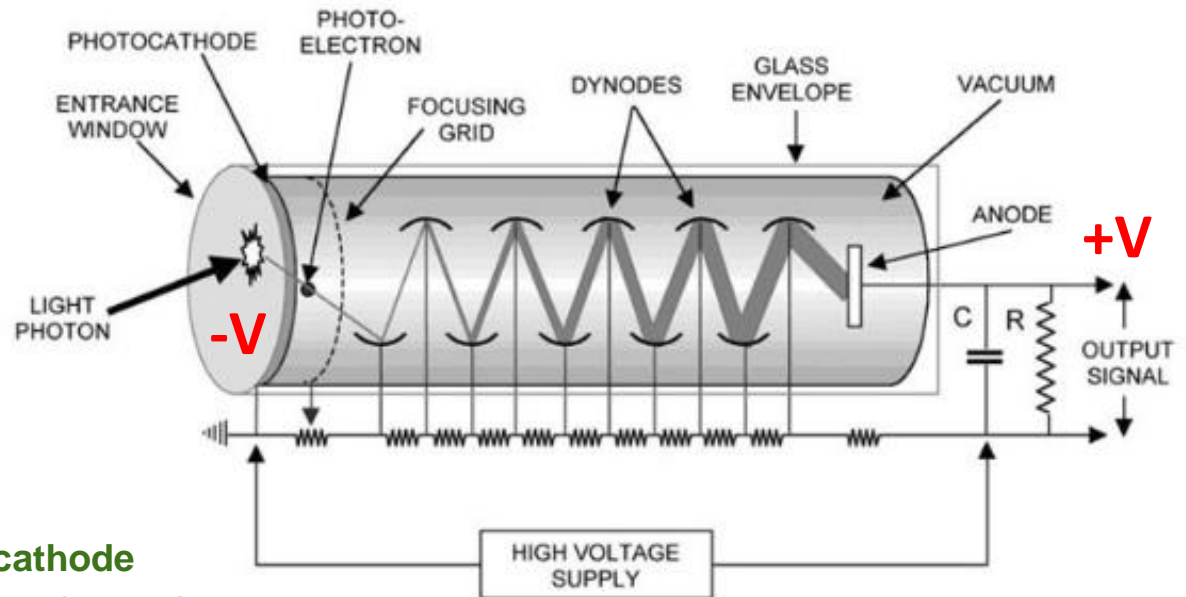


# Extracting Some SiPM Parameters

- Capacitance **CD** of the whole SiPM can be directly measured and is often known from manufacturer's data (30-60pf/mm<sup>2</sup>)
- Forward and reverse I/V curves
  - Reverse I/V curve shines light on the breakdown voltage
  - Forward I/V curve allows to measure RQ, since after a volt or so p-n junction voltage saturates and the further current increase is determined by the RQ ( $dI=dV/RQ$ )



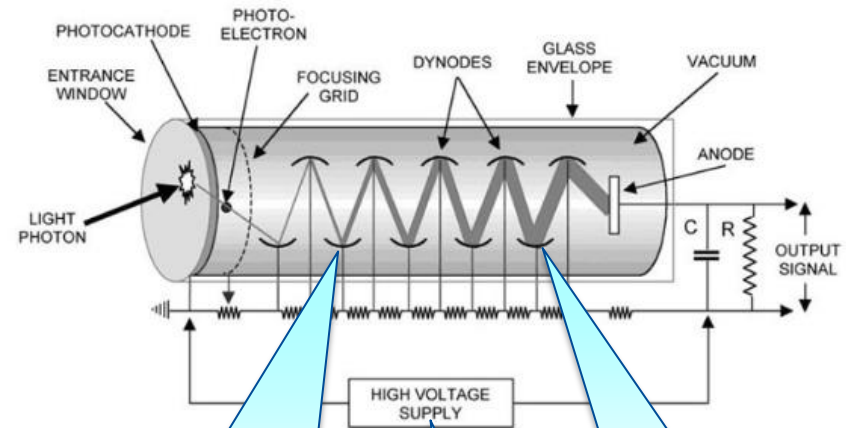
# Vacuum Photo-Multiplier



- **Optically transparent window**
  - Guides light to the photo-cathode
- **Photo-cathode on the inner side of the window**
  - Incident photons release electrons
  - Quantum efficiencies as high as 50%
- **A set of N dynodes with increasing applied voltages**
  - Multiply the number of incident electrons (secondary emission)
- **Anode electrode**
  - Collects output electrons and channels to the registration electronics

# Vacuum Photo-Multiplier

- Overall gain  $G = P(G_i) = (1/P(K_i)) * V^N$  typ.  $1E6-1E7$ 
  - Number of dynodes can be derived from its I/V curve
- Each dynode gain due to secondary emission  
 $G_i = V_i/K_i$  (subject to saturation)
- Single pe resolution is determined by the gain of the first dynode  $1/\sqrt{G_1}$  so higher voltage and better materials are typically used fore the first dynode
  - Amplitude resolution for a single pe at  $G_1=4$  is 50%
- Electrons moving through the dynode system are not nearly relativistic  
 (100eV electron has velocity of 6000 km/s)
  - Signal transient time (in tens of ns)
- Output signal width is small, typically a few ns, despite a long transient time, thanks to electron paths equalization
  - Small output capacitance, a few pf, so 50 ohm readout dos not add to signal deterioration



What's an average secondary emission for a 10-stage tube at a  $1E6$  gain?  
 $=4$

Number of dynodes 8-12, less for the modern tubes

Operating voltage 50-200 V per stage